Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/743,307	ZHANG ET AL.	
Examiner	Art Unit	
John Chavis	2193	•

	.		
	SEAR	CHED	
Class	Subclass	Date	Examiner
717	136	1/21/2007	JC .
708	204	1/21/2007	JC .
			•
	·		

INT	ERFERENC	RENCE SEARCHED	
Class	Subclass	Date	Examiner
			· ·
-			
	·		*

·	DATE	EXMR
West (IBM TDB, DERWENT, EPO, JPO, USPAT, PGPUBS) ANDED WITH WORD SEARCH	1/21/2007	JC
		-
·		